



# SOFT RED WINTER WHEAT

VARIETY	Wheat Class	Regions of Adaptation	Maturity <sup>1</sup>	Height <sup>2</sup>	Test Weight	Standability	Seed Size Range (Seeds/Lb)	Amins	Response to Population [RTP]	Winterhardiness	Response to Fungicide [RTF] <sup>3</sup>	Response to Nitrogen [RTN] <sup>3</sup>	Response to Mitogen [RTM] <sup>3</sup>	Leaf Rust	Stripe Rust	Powdery Mildew	Septoria Leaf Resistance	Stagonospora Blume Disease	Leaf Disease	Barley Yellow Dwarf	Fusarium Head Dwart	Hessian Fly Resistance	Placement on Irrigation		
CP9606	Soft Red	1, 2, 3, 4	3	MS	3	1	Y	11,000-14,000	2	H	M	M	M	2	1	3	3	3	NA	3	2	2	2	Biotype B, D, L, 0	NA
CP8550	Soft Red	1, 2, 3, 4	3	MT	1	2	Y	12,000-14,000	2	L	M	M	M	1	1	3	2	2	NA	3	2	1	1	Biotype L	NA
CP9415	Soft Red	1, 2, 3, 4	4	MS	3	1	Y	10,000-12,000	1	H	H	M	M	1	2	3	2	2	NA	1	3	3	3	Biotype B, D, L, 0	NA
CP9203	Soft Red	1, 2	3	MS	1	2	N	10,000-13,000	2	L	M	H	H	2	1	5	4	4	NA	2	2	2	2	Biotype L	NA
CP8081	Soft Red	1, 2, 3, 4	1	M	2	1	Y	11,000-14,000	2	L	M	M	M	1	2	4	2	2	NA	2	1	2	2	Biotype B, D, L, 0	NA
CP8022	Soft Red	1, 2, 3, 4	3	MS	2	2	Y	11,000-14,000	1	M	M	H	H	3	1	4	2	2	NA	2	1	1	1	Native tol.	NA
CP8007	Soft Red	1, 2	4	S	3	1	N	11,000-14,000	2	M	H	M	M	2	2	2	4	4	NA	2	NA	3	3	NA	NA
CP8045	Soft Red	1,2,3,4	3	M	3	2	Y	11,000-14,000	1	M	M	M	M	2	2	2	2	2	NA	2	NA	2	2	NA	NA
<b>NEW</b> CP8118	Soft Red	3, 6	1	M	3	1	N	11,000-14,000	2	H	L	M	M	2	2	2	3	3	NA	3	2	3	3	Biotype B, D, L, 0	NA

## KEY

- Scale**  
 1 = Excellent  
 2 = Strong  
 3 = Acceptable  
 4 = Manage  
 5 = Not Recommended

Product descriptions and ratings are generated from Answer Plot® trials and/or from the genetics supplier and may change as additional data is gathered.

- 1 Maturity**  
 1 = Early  
 5 = Late
- 2 Height**  
 S = Short  
 M = Medium  
 T = Tall
- 3 RTP/RTM/RTF Ratings**  
 L = Low Response  
 M = Moderate Response  
 H = High Response

The comparison ratings are with CROPLAN® wheats only. These ratings reflect trends observed in research trials, which will change based on various factors, including variations in rainfall, temperature and production patterns.